

Search Notes



Application/Control No.

10/047,001

Examiner

Emmanuel Bayard

Applicant(s)/Patent under Reexamination

DOETSCH ET AL.

Art Unit

2631

SEARCHED

Class	Subclass	Date	Examiner
375	136	5/19/05	218
↑	148	↓	↑
↓	142		
↓	143		
375	130		
370	206		
↑	335		
↓	342	↓	↓
↓	441		
370	522	5/19/05	218

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	136		
375	148		
370	335, 342		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
218	5/19/05	218